

## **PBSS5330XZ Datasheet**



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DiGi Electronics Part Number PBSS5330XZ-DG

Manufacturer Nexperia USA Inc.

Manufacturer Product Number PBSS5330XZ

Description TRANS PNP 30V 3A SOT89

**Detailed Description** Bipolar (BJT) Transistor PNP 30 V 3 A 100MHz 550 m

W Surface Mount SOT-89



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### **Purchase and inquiry**

Manufacturer Product Number:	Manufacturer:
PBSS5330XZ	Nexperia USA Inc.
Series:	Product Status:
	Active
Transistor Type:	Current - Collector (Ic) (Max):
PNP	3 A
Voltage - Collector Emitter Breakdown (Max):	Vce Saturation (Max) @ lb, lc:
30 V	240mV @ 100mA, 2A
Current - Collector Cutoff (Max):	DC Current Gain (hFE) (Min) @ Ic, Vce:
100nA (ICBO)	175 @ 1A, 2V
Power - Max:	Frequency - Transition:
550 mW	100MHz
Operating Temperature:	Grade:
150°C (TJ)	Automotive
Qualification:	Mounting Type:
AEC-Q100	Surface Mount
Package / Case:	Supplier Device Package:
TO-243AA	SOT-89
Base Product Number:	
PBSS5330	

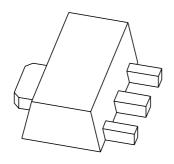
### **Environmental & Export classification**

8541.21.0075

RoHS Status:	Moisture Sensitivity Level (MSL):
ROHS3 Compliant	1 (Unlimited)
REACH Status:	ECCN:
REACH Unaffected	EAR99
HTSUS:	

### **DISCRETE SEMICONDUCTORS**

# DATA SHEET



PBSS5330X 30 V, 3 A PNP low V<sub>CEsat</sub> (BISS) transistor

Product data sheet Supersedes data of 2003 Nov 28 2004 Nov 03



# 30 V, 3 A PNP low V<sub>CEsat</sub> (BISS) transistor

### PBSS5330X

#### **FEATURES**

- SOT89 (SC-62) package
- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability: I<sub>C</sub> and I<sub>CM</sub>
- · Higher efficiency leading to less heat generation
- Reduced printed-circuit board requirements.

#### **APPLICATIONS**

- Power management
  - DC/DC converters
  - Supply line switching
  - Battery charger
  - LCD backlighting.
- · Peripheral drivers
  - Driver in low supply voltage applications (e.g. lamps and LEDs)
  - Inductive load driver (e.g. relays, buzzers and motors).

#### **DESCRIPTION**

PNP low  $V_{\text{CEsat}}$  transistor in a SOT89 plastic package.

#### **MARKING**

TYPE NUMBER	MARKING CODE <sup>(1)</sup>
PBSS5330X	*1S

#### Note

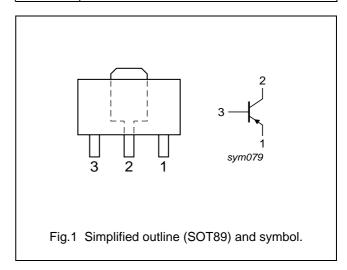
- 1. \* = p: Made in Hong Kong.
  - \* = t: Made in Malaysia.
  - \* = W: Made in China.

#### **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	UNIT
V <sub>CEO</sub>	collector-emitter voltage	-30	V
I <sub>C</sub>	collector current (DC)	-3	Α
I <sub>CM</sub>	peak collector current	-5	Α
R <sub>CEsat</sub>	equivalent on-resistance	107	mΩ

#### **PINNING**

PIN	DESCRIPTION
1	emitter
2	collector
3	base



#### ORDERING INFORMATION

TYPE NUMBER		PACKAGE	
TIFE NOMBER	NAME	DESCRIPTION	VERSION
PBSS5330X	SC-62	plastic surface mounted package; collector pad for good heat transfer; 3 leads	SOT89

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#### LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

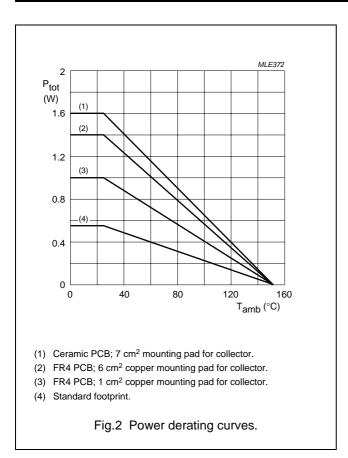
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	-30	٧
$V_{CEO}$	collector-emitter voltage	open base	_	-30	٧
$V_{EBO}$	emitter-base voltage	open collector	-	-6	٧
I <sub>C</sub>	collector current (DC)	note 4	_	-3	Α
I <sub>CM</sub>	peak collector current	limited by T <sub>j(max)</sub>	_	<b>-</b> 5	Α
I <sub>B</sub>	base current (DC)		-	-0.5	Α
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> ≤ 25 °C			
		note 1	_	550	mW
		note 2	_	1	W
		note 3	_	1.4	W
		note 4	_	1.6	W
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		_	150	°C
T <sub>amb</sub>	ambient temperature		-65	+150	°C

#### **Notes**

- 1. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; standard footprint.
- 2. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; mounting pad for collector 1 cm<sup>2</sup>.
- 3. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; mounting pad for collector 6 cm<sup>2</sup>.
- 4. Device mounted on a ceramic printed-circuit board 7 cm<sup>2</sup>, single-sided copper, tin-plated.

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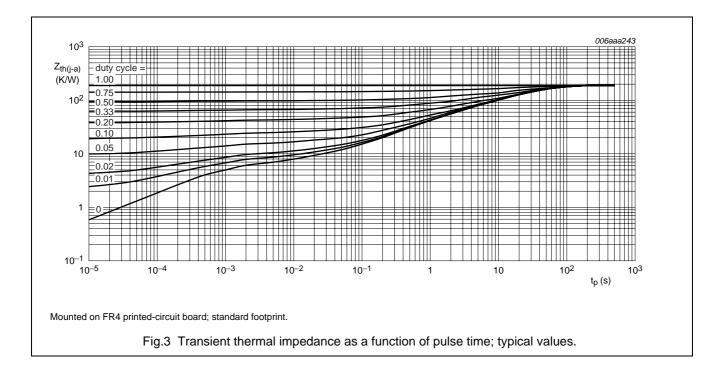
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#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	in free air		
		note 1	225	K/W
		note 2	125	K/W
		note 3	90	K/W
		note 4	80	K/W
R <sub>th(j-s)</sub>	thermal resistance from junction to soldering point		16	K/W

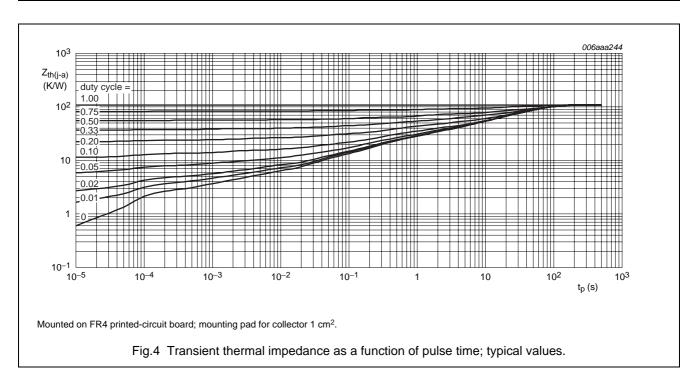
#### **Notes**

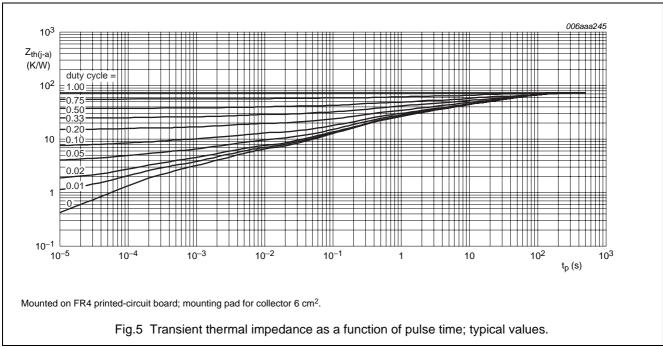
- 1. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; standard footprint.
- 2. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; mounting pad for collector 1 cm<sup>2</sup>.
- 3. Device mounted on a FR4 printed-circuit board; single-sided copper; tin-plated; mounting pad for collector 6 cm<sup>2</sup>.
- 4. Device mounted on a ceramic printed-circuit board 7 cm<sup>2</sup>, single-sided copper, tin-plated.



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# 30 V, 3 A PNP low $V_{CEsat}$ (BISS) transistor

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#### **CHARACTERISTICS**

 $T_{amb}$  = 25 °C unless otherwise specified.

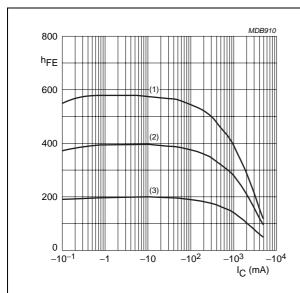
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I <sub>CBO</sub>	collector-base cut-off current	$V_{CB} = -30 \text{ V}; I_E = 0 \text{ A}$	_	_	-100	nA
		$V_{CB} = -30 \text{ V}; I_E = 0 \text{ A}; T_j = 150 ^{\circ}\text{C}$	_	_	-50	μΑ
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = -30 \text{ V}; V_{BE} = 0 \text{ V}$	_	-	-100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_{C} = 0 \text{ A}$	_	_	-100	nA
h <sub>FE</sub>	DC current gain	V <sub>CE</sub> = −2 V				
		$I_{\rm C} = -0.1  {\rm A}$	200	_	_	
		$I_{\rm C} = -0.5  {\rm A}$	200	_	_	
		$I_{C} = -1 \text{ A}$ ; note 1	175	_	450	
		$I_{C} = -2 \text{ A}$ ; note 1	140	_	_	
		$I_{\rm C} = -3$ A; note 1	100	_	_	
V <sub>CEsat</sub>	collector-emitter saturation	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$	_	_	-70	mV
	voltage	$I_C = -1 \text{ A}; I_B = -50 \text{ mA}$	_	_	-130	mV
		$I_C = -2 \text{ A}; I_B = -100 \text{ mA}$	_	_	-240	mV
		$I_C = -3 \text{ A}$ ; $I_B = -300 \text{ mA}$ ; note 1	_	_	-320	mV
R <sub>CEsat</sub>	equivalent on-resistance	$I_C = -3 \text{ A}$ ; $I_B = -300 \text{ mA}$ ; note 1	_	80	107	mΩ
V <sub>BEsat</sub>	base-emitter saturation voltage	$I_C = -2 \text{ A}; I_B = -100 \text{ mA}$	_	_	-1.1	V
		$I_C = -3 \text{ A}$ ; $I_B = -300 \text{ mA}$ ; note 1	_	_	-1.2	V
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}$	-1.0	_	_	V
f <sub>T</sub>	transition frequency	I <sub>C</sub> = -100 mA; V <sub>CE</sub> = -5 V; f = 100 MHz	100	_	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A}; f = 1 \text{ MHz}$	_	-	45	pF

#### Note

1. Pulse test:  $t_p \leq 300~\mu s;~\delta \leq 0.02.$ 

# 30 V, 3 A PNP low $V_{CEsat}$ (BISS) transistor

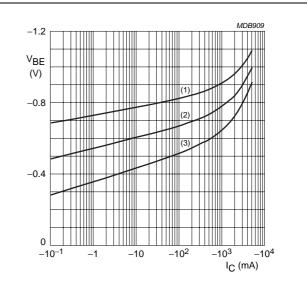
### PBSS5330X



 $V_{CE} = -2 V$ .

- (1)  $T_{amb} = 100 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

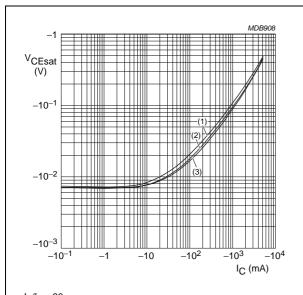
Fig.6 DC current gain as a function of collector current; typical values.



 $V_{CE} = -2 V$ .

- (1)  $T_{amb} = -55 \, ^{\circ}C$ .
- (2) T<sub>amb</sub> = 25 °C.
- (3)  $T_{amb} = 100 \, ^{\circ}C$ .

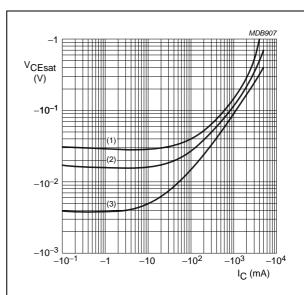
Fig.7 Base-emitter voltage as a function of collector current; typical values.



 $I_{\rm C}/I_{\rm B} = 20.$ 

- (1)  $T_{amb} = 100 \, ^{\circ}C$ .
- (2)  $T_{amb} = 25 \, ^{\circ}C$ .
- (3)  $T_{amb} = -55 \, ^{\circ}C$ .

Fig.8 Collector-emitter saturation voltage as a function of collector current; typical values.



 $T_{amb}$  = 25 °C.

- (1)  $I_C/I_B = 100$
- (2)  $I_C/I_B = 50$ .
- (3)  $I_C/I_B = 10$ .

Fig.9 Collector-emitter saturation voltage as a function of collector current; typical values.

### 30 V, 3 A PNP low V<sub>CEsat</sub> (BISS) transistor

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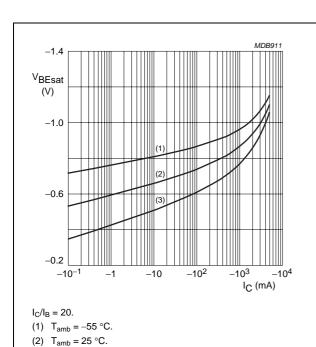
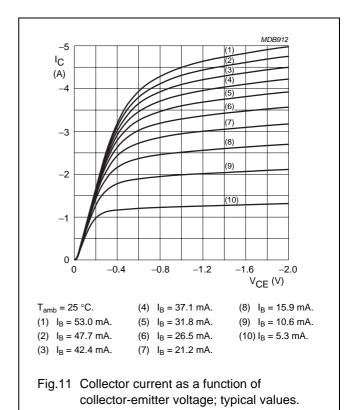
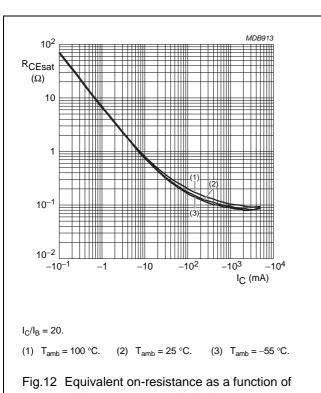


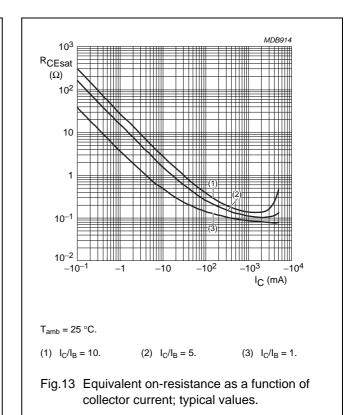
Fig.10 Base-emitter saturation voltage as a function of collector current; typical values.

(3)  $T_{amb} = 100 \, ^{\circ}C$ .





collector current; typical values.



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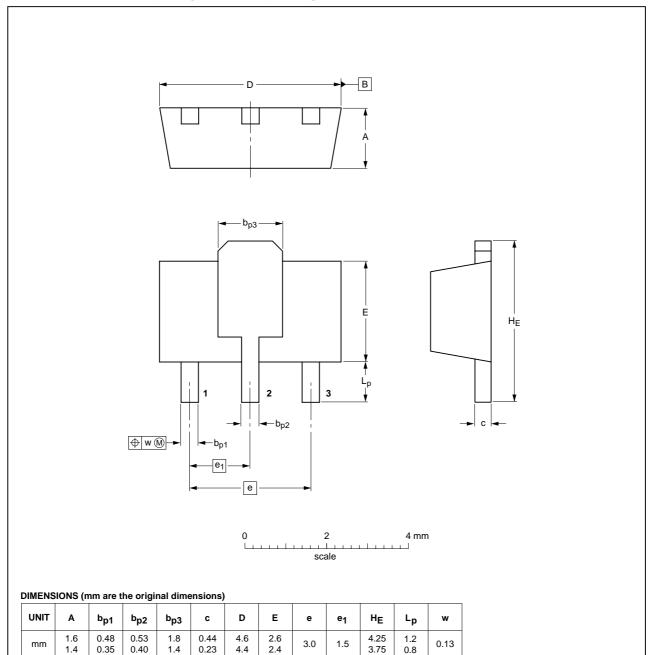
30 V, 3 A PNP low  $V_{CEsat}$  (BISS) transistor

PBSS5330X

#### **PACKAGE OUTLINE**

### Plastic surface-mounted package; collector pad for good heat transfer; 3 leads

SOT89



OUTLINE		JTLINE REFERENCES		EUROPEAN	ICCUIE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT89		TO-243	SC-62		<del>04-08-03</del> 06-03-16

## 30 V, 3 A PNP low V<sub>CEsat</sub> (BISS) transistor

PBSS5330X

#### **DATA SHEET STATUS**

DOCUMENT STATUS <sup>(1)</sup>	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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2004 Nov 03

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#### **Customer notification**

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#### **Contact information**

For additional information please visit: http://www.nxp.com
For sales offices addresses send e-mail to: salesaddresses@nxp.com

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